

**AMENDMENTS TO THE ABSTRACT**

Please amend the Abstract as below. A clean copy of the abstract is provided as a separate attachment to this response.

The invention provides a method and apparatus for temporarily isolating a die from other ~~die~~ dies on a wafer commonly connected to one or more common conductors. The conductors are connected to each die through a temporary isolation device, such as a diode. The common conductor supplies a signal to all ~~die~~ dies during one set of test procedures, while the temporary isolation device can be used to isolate a die from the common conductor during another set of test procedures.